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| Search Notes  | Application/Control No. 10823400 | Applicant(s)/Patent Under Reexamination BAUER ET AL. |
| | Examiner Tae H Yoon | Art Unit 1796 |

| SEARCHED | | | |
|----------|----------|-----------|----------|
| Class | Subclass | Date | Examiner |
| 524 | 437 | 2/16/2008 | /TY/ |
| ATD | | 10/24/09 | /TY/ |
| ATD | | 2/12/10 | /TY/ |

| SEARCH NOTES | | | |
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| Search Notes | | Date | Examiner |
| EAST | | 2/16 and 2/18/2008 | /TY/ |
| EAST | | 9/13/08 | /TY/ |
| EAST | | 2/12/09 | /TY/ |

| INTERFERENCE SEARCH | | | |
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| Class | Subclass | Date | Examiner |
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